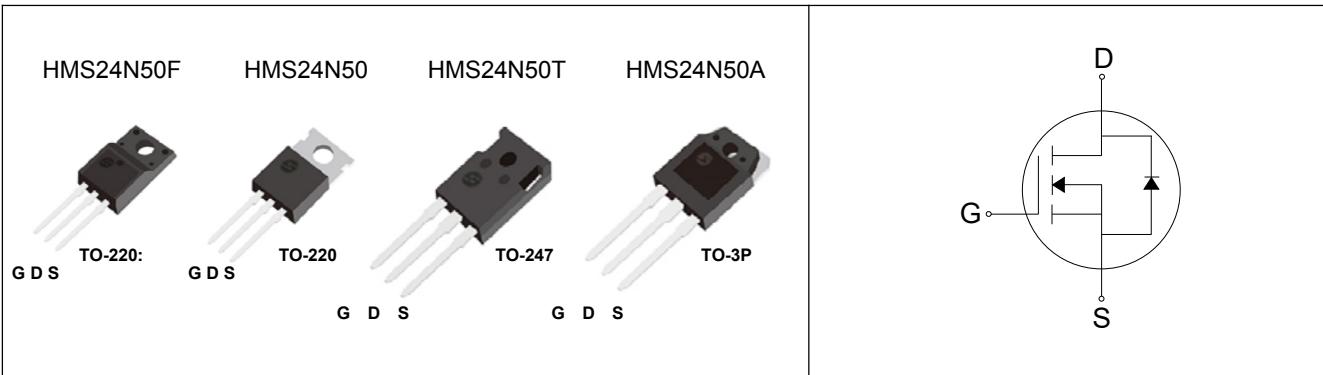


## General Description

This Power MOSFET is produced using H&M Semi's Advanced Super-Junction technology. This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for AC/DC power conversion

## Features

- 25A, 500V, RDS(on) typ.= 0.12Ω@VGS = 10 V
- Low gate charge ( typical 70nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



## Absolute Maximum Ratings

TC = 25°C unless otherwise noted

Symbol	Parameter	TO-220/247/3P	TO-220F	Units
VDSS	Drain-Source Voltage	500		V
ID	Drain Current - Continuous (TC = 25°C)	25	25*	A
	- Continuous (TC = 100°C)	15	15*	A
IDM	Drain Current - Pulsed (Note 1)	70	70*	A
VGSS	Gate-Source Voltage	±30		V
EAS	Single Pulsed Avalanche Energy (Note 2)	485		mJ
IAR	Avalanche Current (Note 1)	3.5		A
EAR	Repetitive Avalanche Energy (Note 1)	1		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	15		V/ns
PD	Power Dissipation (TC = 25°C)	151	31	W
	- Derate above 25°C	0.67	0.25	W/°C
TJ, TSTG	Operating and Storage Temperature Range	-55 to +150		°C
TL	Maximum lead temperature for soldering purposes,		300	
	1/8" from case for 5 seconds			°C

\*Drain current limited by maximum junction temperature.

## Thermal Characteristics

Symbol	Parameter	Value		Units
		TO220/247/3P	TO220F	
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case	0.83	4.0	°C/W
R <sub>θJS</sub>	Thermal Resistance, Case-to-Sink Typ.	0.5	-	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	62	80	°C/W

## Electrical Characteristics ( $T_C = 25^\circ C$ unless otherwise noted )

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
BVDSS	Drain-Source Breakdown Voltage	VGS = 0V, ID = 250uA, TJ=25°C	500	-	-	V
		VGS = 0V, ID = 250uA, TJ=150°C	-	550	-	V
$\Delta BVDSS$ $\Delta TJ$	Breakdown Voltage Temperature coefficient	ID = 250uA, referenced to 25°C	-	0.6	-	V/°C
		VDS = 500V, VGS = 0V	-	-	1	uA
IDSS	Drain-Source Leakage Current	VDS = 400V, TC = 125 °C	-	-	10	uA
		VGS = 30V, VDS = 0V	-	-	100	nA
IGSS	Gate-Source Leakage, Forward	VGS = -30V, VDS = 0V	-	-	-100	nA
	Gate-source Leakage, Reverse					
<b>On Characteristics</b>						
VGS(th)	Gate Threshold Voltage	VDS = VGS, ID = 250uA	2.5	-	4.5	V
RDS(ON)	Static Drain-Source On-state Resistance	VGS = 10 V, ID = 12.5A	-	0.12	0.14	Ω
<b>Dynamic Characteristics</b>						
Ciss	Input Capacitance	VGS = 0 V, VDS = 25V, f = 1MHz	-	1440	-	pF
Coss	Output Capacitance		-	370	-	
Crss	Reverse Transfer Capacitance		-	11	-	
<b>Dynamic Characteristics</b>						
td(on)	Turn-on Delay Time	VDD = 400V, ID = 12A, RG = 20Ω	-	15	-	nS
tr	Rise Time		-	11	-	
td(off)	Turn-off Delay Time		-	110	-	
tf	Fall Time		-	9	-	
Qg	Total Gate Charge	VDS = 400V, VGS = 10V, ID = 12A	-	70	-	nC
Qgs	Gate-Source Charge		-	7.8	-	
Qgd	Gate-Drain Charge(Miller Charge)		-	9	-	

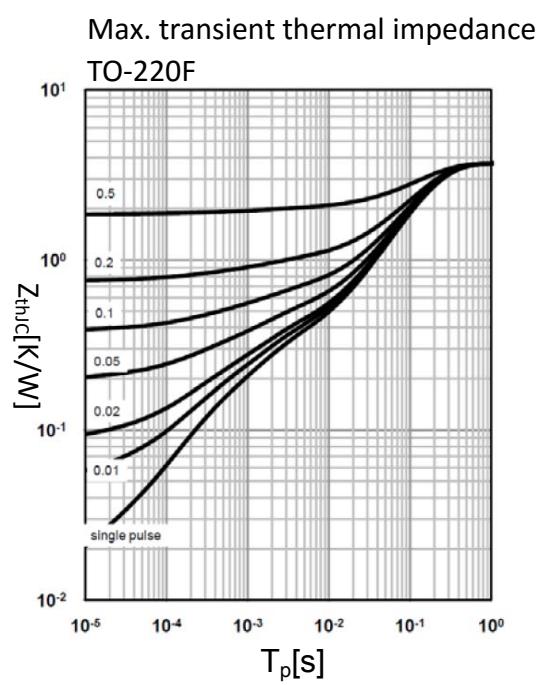
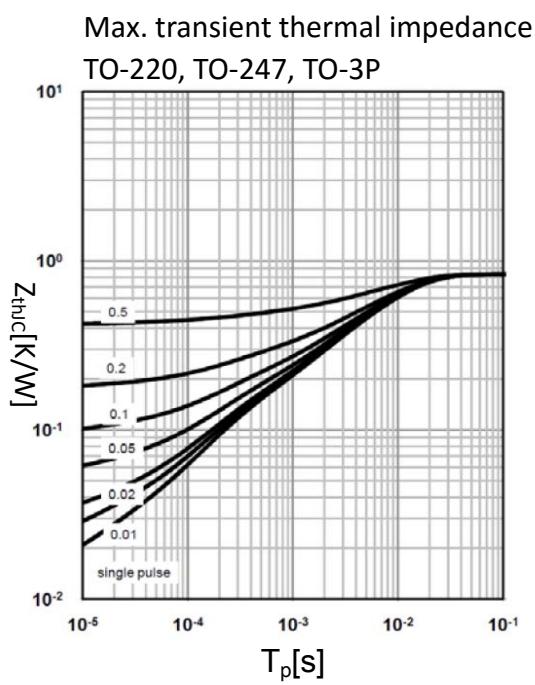
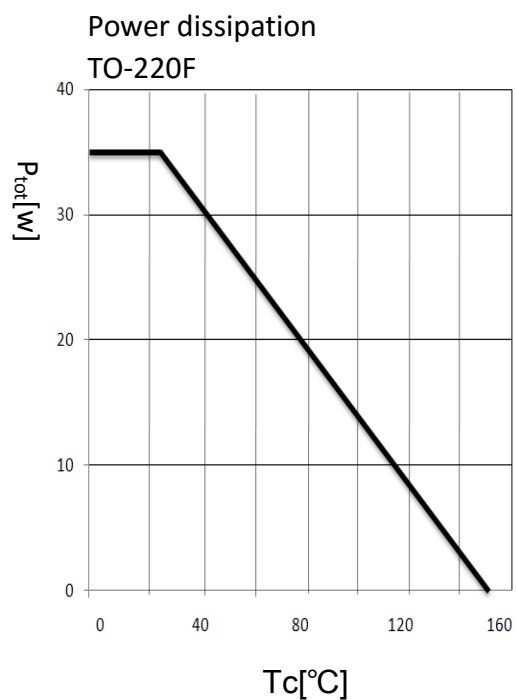
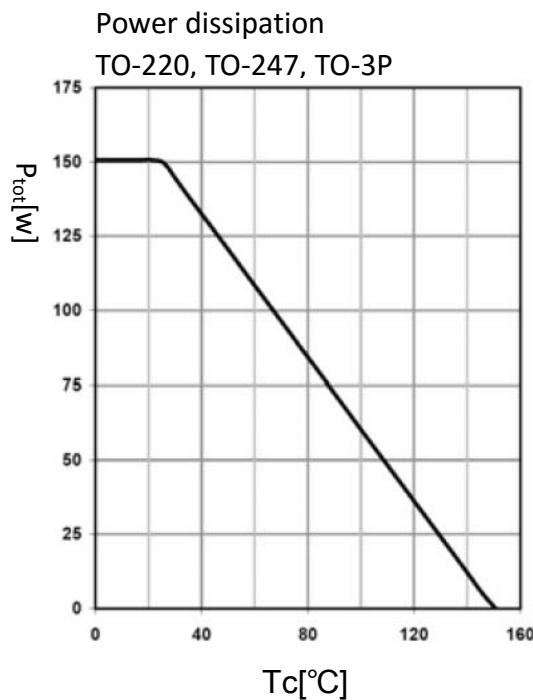
## Source-Drain Diode Ratings and Characteristics

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit.
IS	Maximum Continuous Drain-Source Diode Forward Current	IS = 12A, VGS = 0V	-	-	25	A
ISM	Maximum Pulsed Drain-Source Diode Forward Current		-	-	70	
VSD	Diode Forward Voltage	IS = 12A, VGS = 0V	-	-	1.5	V
trr	Reverse Recovery Time	IS = 12A, VGS=0V, dI/dt=100A/us	-	475	-	nS
Qrr	Reverse Recovery Charge		-	5.8	-	uC

## NOTES

- Repeatability rating : pulse width limited by junction temperature
- $I_{AS} = 3.5A$ ,  $VDD = 50V$ ,  $RG = 25\Omega$ , Starting  $TJ = 25^\circ C$
- $ISD \leq ID$ ,  $dI/dt \leq 200A/\mu s$ ,  $VDD \leq BVDSS$ , Starting  $TJ = 25^\circ C$
- Pulse Test : Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$
- Essentially independent of operating temperature.

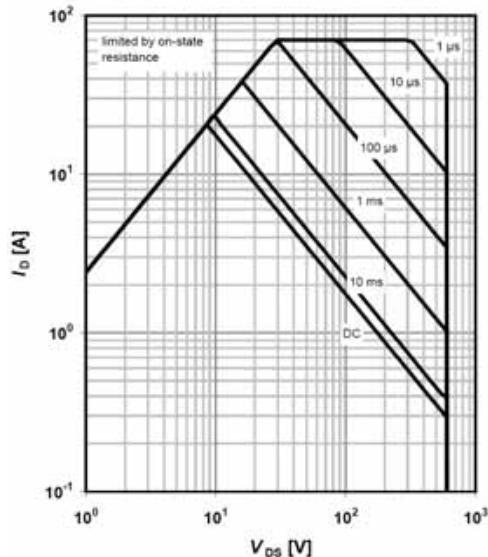
## Typical Performance Characteristics



## Typical Performance Characteristics

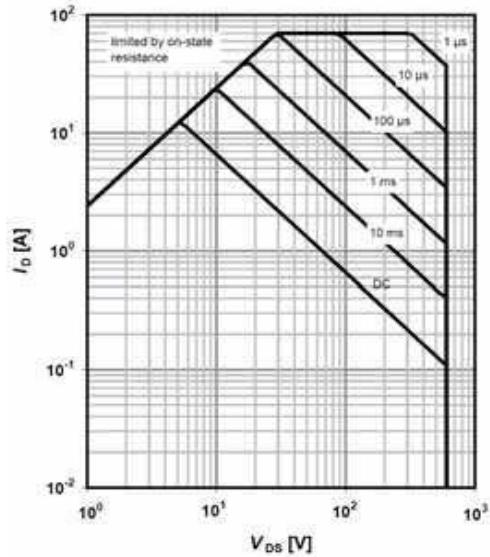
Safe operating area  $T_C=25\text{ }^{\circ}\text{C}$

TO-220, TO-247, TO-3P



Safe operating area  $T_C=25\text{ }^{\circ}\text{C}$

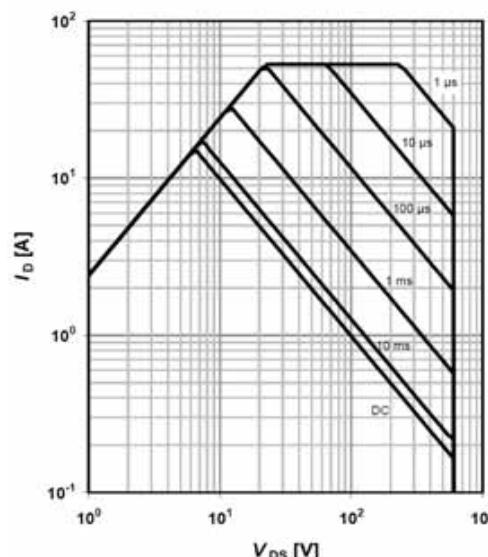
TO-220F



$$I_D=f(V_{DS}); T_C=25\text{ }^{\circ}\text{C}; V_{GS} > 7V; D=0; \text{parameter } t_p$$

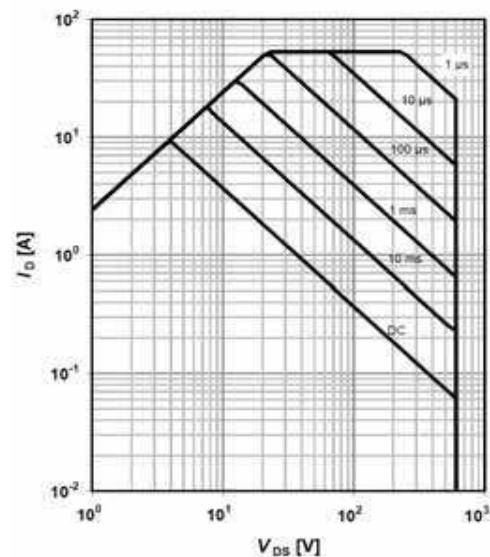
Safe operating area  $T_C=80\text{ }^{\circ}\text{C}$

TO-220, TO-247, TO-3P



Safe operating area  $T_C=80\text{ }^{\circ}\text{C}$

TO-220F

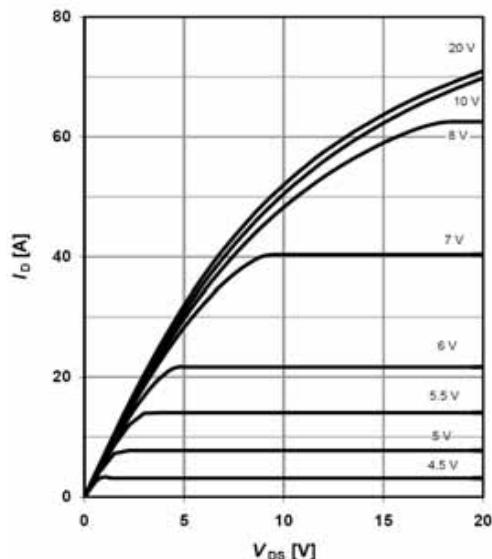


$$I_D=f(V_{DS}); T_C=80\text{ }^{\circ}\text{C}; V_{GS} > 7V; D=0; \text{parameter } t_p$$

## Typical Performance Characteristics

Typ. output characteristics

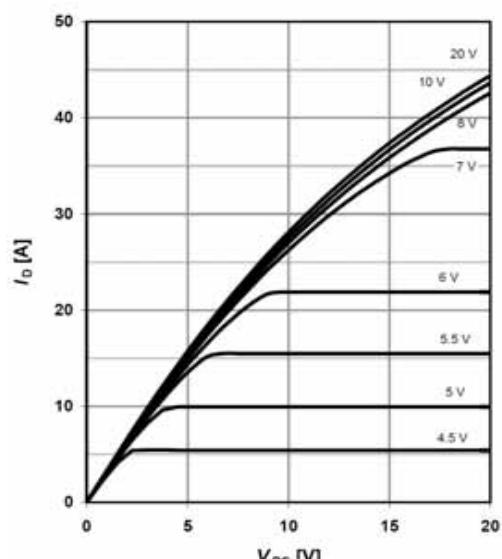
$T_j=25\text{ }^{\circ}\text{C}$



$$I_D=f(V_{DS}); T_j=25\text{ }^{\circ}\text{C}; \text{parameter: } V_{GS}$$

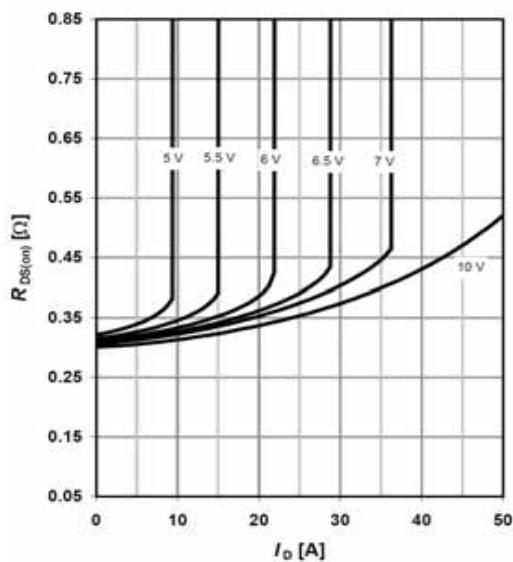
Typ. output characteristics

$T_j=125\text{ }^{\circ}\text{C}$



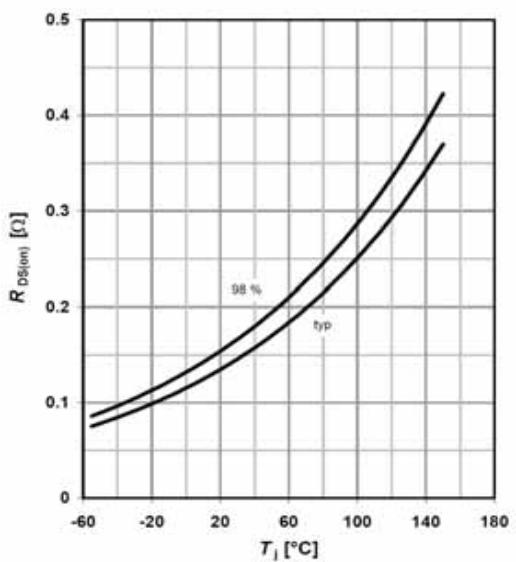
$$I_D=f(V_{DS}); T_j=125\text{ }^{\circ}\text{C}; \text{parameter: } V_{GS}$$

Typ. drain-source on-state resistance



$$R_{DS(on)}=f(I_D); T_j=125\text{ }^{\circ}\text{C}; \text{parameter: } V_{GS}$$

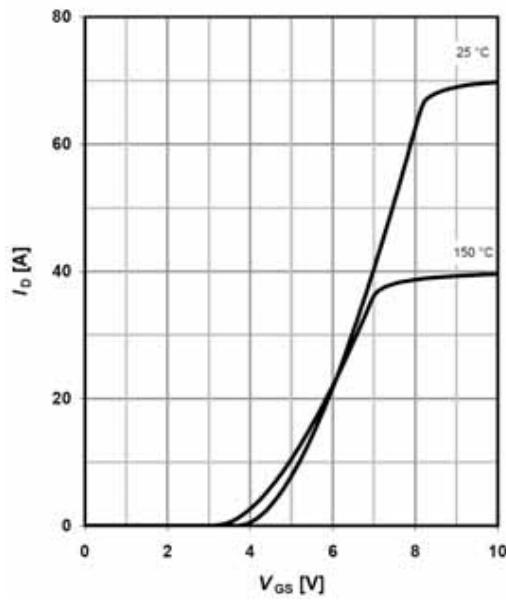
Typ. drain-source on-state resistance



$$R_{DS(on)}=f(T_j); I_D=12\text{A}; V_{GS}=10\text{ V}$$

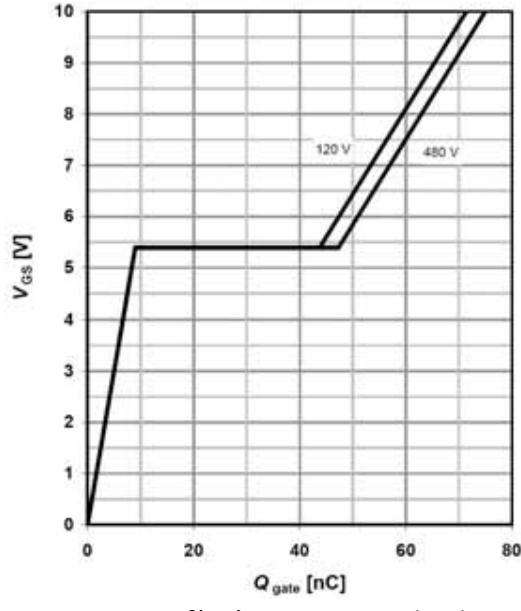
## Typical Performance Characteristics

Typ. transfer characteristics



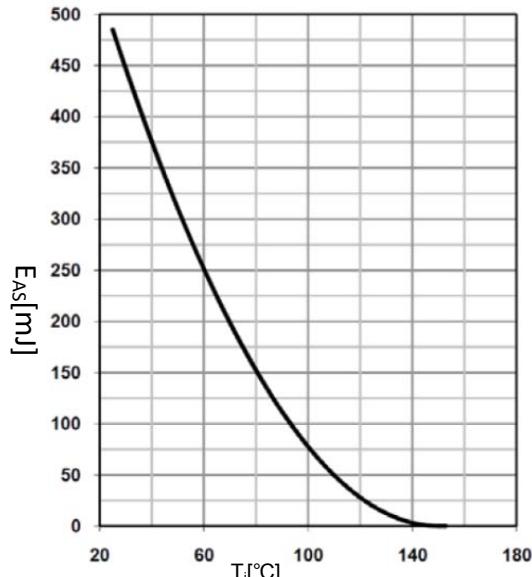
$$I_D = f(V_{GS}); V_{DS} = 20\text{ V}$$

Typ. gate charge



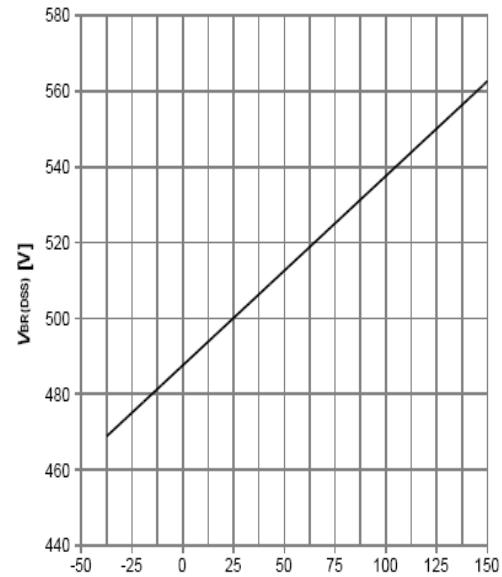
$$V_{GS} = f(Q_g), I_D = 12\text{ A} \quad \text{pulsed}$$

Avalanche energy



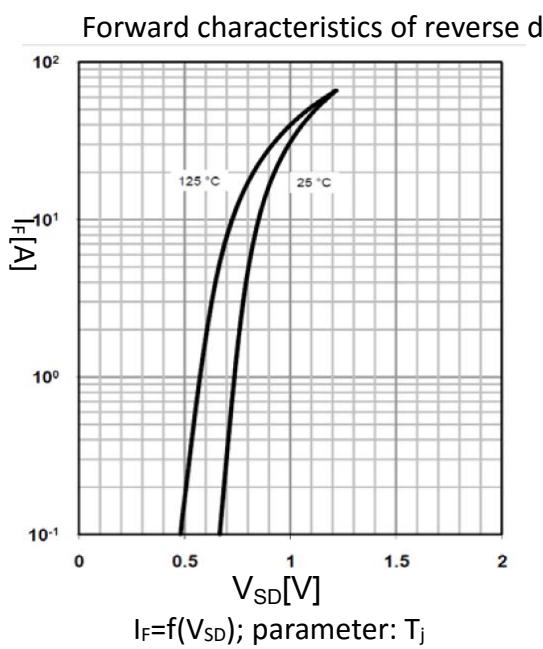
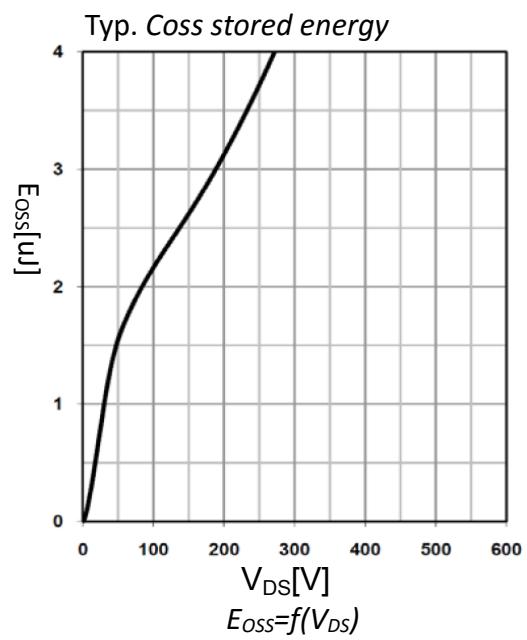
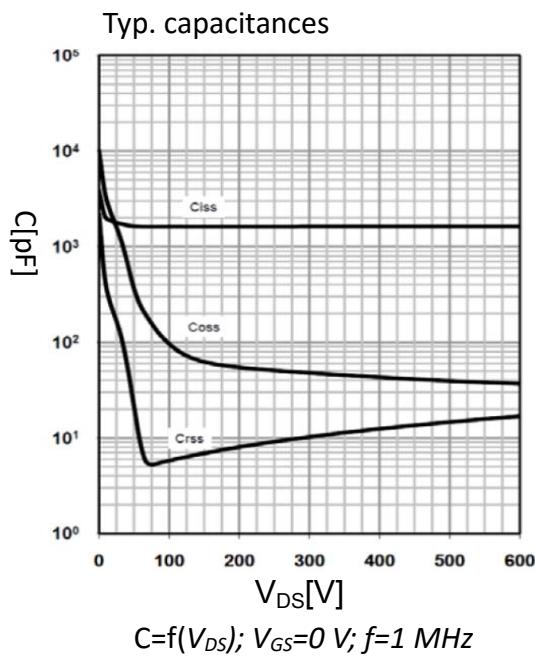
$$E_{AS} = f(T_j); I_D = 3.5\text{ A}; V_{DD} = 50\text{ V}$$

Drain-source breakdown voltage

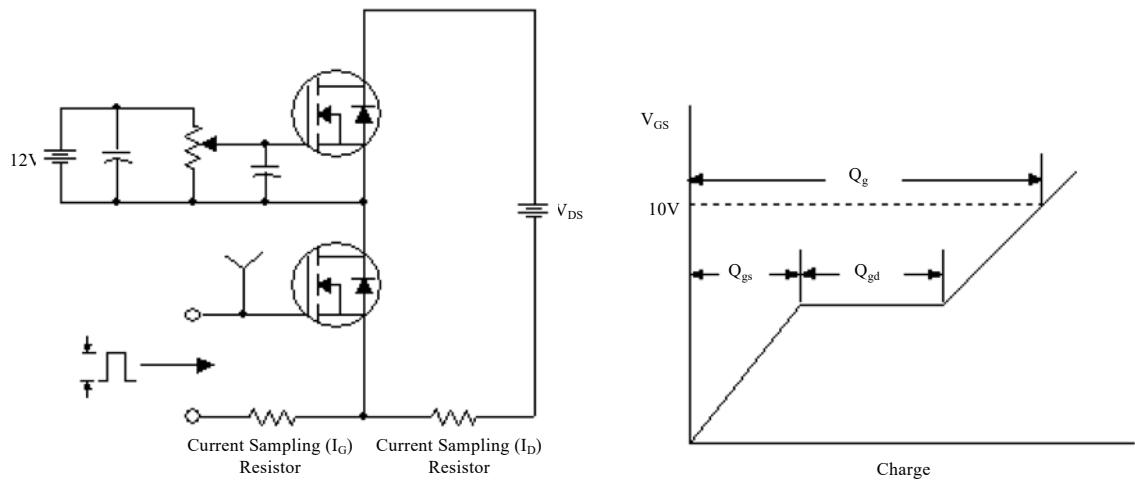


$$V_{BR(DSS)} = f(T_j); I_D = 0.25\text{ mA}$$

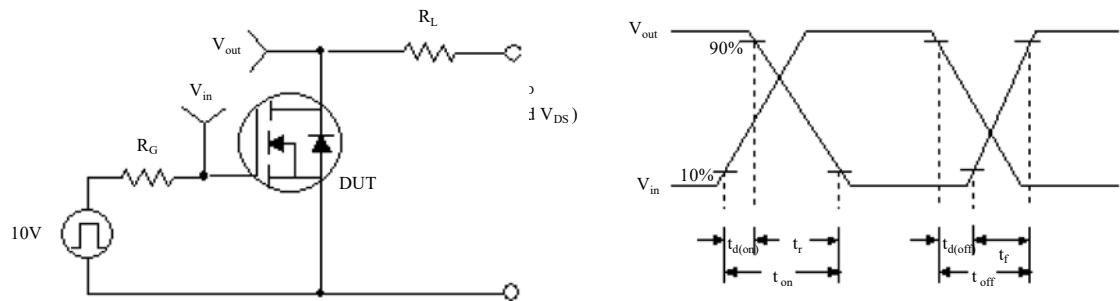
## Typical Performance Characteristics



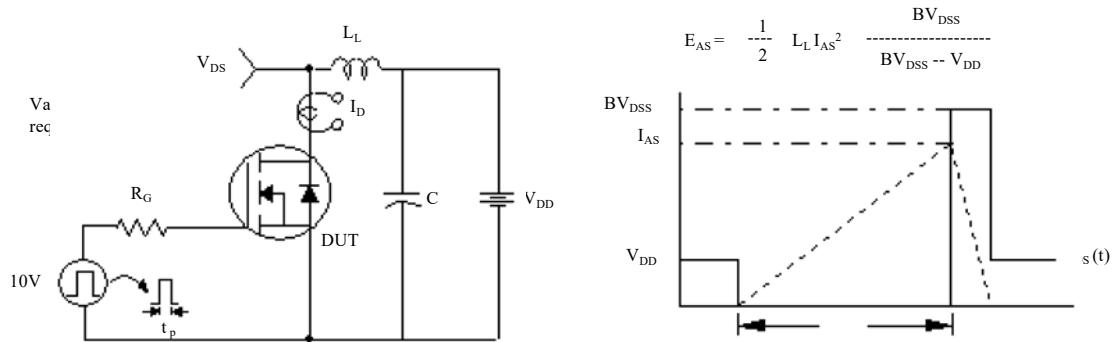
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching Test Circuit & Waveforms



## Peak Diode Recovery dv/dt Test Circuit & Waveforms

